







CSD25484F4 SLPS551B - MAY 2015 - REVISED FEBRUARY 2022

#### CSD25484F4 -20-V P-Channel FemtoFET™ MOSFET

#### 1 Features

- Low on-resistance
- Ultra-low Q<sub>a</sub> and Q<sub>ad</sub>
- Low-threshold voltage
- Ultra-small footprint (0402 case size)
  - 1.0 mm × 0.6 mm
- · Ultra-low profile
  - 0.2-mm height
- Integrated ESD protection diode
  - Rated > 4-kV HBM
  - Rated > 2-kV CDM
- Lead and halogen free
- RoHS compliant

## 2 Applications

- Optimized for load switch applications
- Optimized for general purpose switching applications
- **Battery applications**
- Handheld and mobile applications

## 3 Description

This 80-mΩ, –20-V, P-Channel FemtoFET™ MOSFET is designed and optimized to minimize the footprint in many handheld and mobile applications. This technology is capable of replacing standard small signal MOSFETs while providing at least a 60% reduction in footprint size.

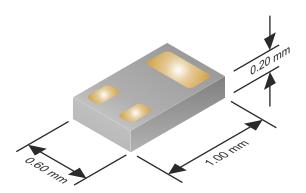


Figure 3-1. Typical Package Dimensions

#### **Product Summary**

T <sub>A</sub> = 25°	С	TYPICAL VA	UNIT	
V <sub>DS</sub>	Drain-to-source voltage -20			
Qg	Gate charge total (-4.5 V)	1090		рC
Q <sub>gd</sub>	Gate charge gate-to-drain	150	рC	
		V <sub>GS</sub> = -1.8 V	405	
B	Drain-to-source	V <sub>GS</sub> = -2.5 V	150	mΩ
R <sub>DS(on)</sub>	on-resistance	V <sub>GS</sub> = -4.5 V	93	11122
		V <sub>GS</sub> = -8.0 V	80	
V <sub>GS(th)</sub>	Threshold voltage	-0.95	V	

#### **Device Information**

DEVICE	QTY	MEDIA	PACKAGE <sup>(1)</sup>	SHIP
CSD25484F4	3000		Femto (0402)	Таре
CSD25484F4T	250	7-Inch Reel	1.00-mm × 0.60-mm Land Grid Array (LGA)	and Reel

For all available packages, see the orderable addendum at the end of the data sheet.

#### Absolute Maximum Patings

Absolute Maximum Natings							
T <sub>A</sub> = 25	s°C	VALUE	UNIT				
$V_{DS}$	Drain-to-source voltage	-20	V				
V <sub>GS</sub>	Gate-to-source voltage	-12	٧				
I <sub>D</sub>	Continuous drain current <sup>(1)</sup>	-2.5	Α				
I <sub>DM</sub>	Pulsed drain current <sup>(1)</sup> (2)	-22	Α				
	Continuous gate clamp current	-35	mA				
I <sub>G</sub>	Pulsed gate clamp current <sup>(2)</sup>	-350	MA				
P <sub>D</sub>	Power dissipation <sup>(1)</sup>	500	mW				
V	Human-body model (HBM)	4	kV				
V <sub>(ESD)</sub>	Charged-device model (CDM)	2	KV				
T <sub>J</sub> , T <sub>stg</sub>	Operating junction, storage temperature	-55 to 150	°C				

- Typical  $R_{\theta JA} = 85^{\circ}C/W \text{ on } 1-\text{in}^2 (6.45-\text{cm}^2), 2-\text{oz}$ (0.071-mm) thick Cu pad on a 0.06-in (1.52-mm) thick FR4 PCB.
- Pulse duration ≤ 100 µs, duty cycle ≤ 1%. (2)

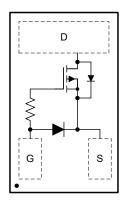


Figure 3-2. Top View



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Changes from Revision * (May 2015) to Revision	ı A (August 2017) Page
<ul> <li>Added the Section 6.1 and the Section 6section.</li> </ul>	7



## **5 Specifications**

## **5.1 Electrical Characteristics**

T<sub>A</sub> = 25°C (unless otherwise stated)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC	CHARACTERISTICS					
BV <sub>DSS</sub>	Drain-to-source voltage	V <sub>GS</sub> = 0 V, I <sub>DS</sub> = -250 μA	-20			V
I <sub>DSS</sub>	Drain-to-source leakage current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -16 V			-100	nA
I <sub>GSS</sub>	Gate-to-source leakage current	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = -12 V			-50	nA
V <sub>GS(th)</sub>	Gate-to-source threshold voltage	$V_{DS} = V_{GS}, I_{DS} = -250 \mu A$	-0.7	-0.95	-1.2	V
		V <sub>GS</sub> = -1.8 V, I <sub>DS</sub> = -0.1 A		405	825	
В	Drain to course on registence	$V_{GS} = -2.5 \text{ V}, I_{DS} = -0.5 \text{ A}$		150	180	<b>~</b> 0
R <sub>DS(on)</sub>	Drain-to-source on-resistance	$V_{GS} = -4.5 \text{ V}, I_{DS} = -0.5 \text{ A}$		93	109	mΩ
		$V_{GS} = -8 \text{ V}, I_{DS} = -0.5 \text{ A}$		80	94	
9 <sub>fs</sub>	Transconductance	$V_{DS} = -10 \text{ V}, I_{DS} = -0.5 \text{ A}$		3.5		S
DYNAMI	C CHARACTERISTICS					
C <sub>iss</sub>	Input capacitance			175	230	pF
C <sub>oss</sub>	Output capacitance	$V_{GS} = 0 \text{ V, } V_{DS} = -10 \text{ V,}$ f = 1  MHz		78	102	pF
C <sub>rss</sub>	Reverse transfer capacitance	, . wz		5.5	7.2	pF
R <sub>G</sub>	Series gate resistance			20		Ω
Q <sub>g</sub>	Gate charge total (–4.5 V)			1090	1415	рС
Q <sub>gd</sub>	Gate charge gate-to-drain	V - 40VI - 05A		150		рС
Q <sub>gs</sub>	Gate charge gate-to-source	V <sub>DS</sub> = -10 V, I <sub>DS</sub> = -0.5 A		350		рС
Q <sub>g(th)</sub>	Gate charge at V <sub>th</sub>			210		рС
Q <sub>oss</sub>	Output charge	V <sub>DS</sub> = -10 V, V <sub>GS</sub> = 0 V		1290		рС
t <sub>d(on)</sub>	Turnon delay time			9.5		ns
t <sub>r</sub>	Rise time	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V},$		5		ns
t <sub>d(off)</sub>	Turnoff delay time	$I_{DS} = -0.5 \text{ A}, R_G = 10 \Omega$		18		ns
t <sub>f</sub>	Fall Time			8.5		ns
DIODE C	CHARACTERISTICS		,			
V <sub>SD</sub>	Diode forward voltage	I <sub>SD</sub> = -0.5 A, V <sub>GS</sub> = 0 V		-0.75		V
Q <sub>rr</sub>	Reverse recovery charge	V = 40 V I = 0.5 A didt = 400 A free	,	970		рС
t <sub>rr</sub>	Reverse recovery time	$V_{DS}$ = -10 V, $I_F$ = -0.5 A, di/dt = 100 A/ $\mu$ s		7.5		ns

## **5.2 Thermal Information**

 $T_A = 25$ °C (unless otherwise stated)

	THERMAL METRIC	TYPICAL VALUES	UNIT
D	Junction-to-ambient thermal resistance <sup>(1)</sup>	85	°C/W
$R_{\theta JA}$	Junction-to-ambient thermal resistance <sup>(2)</sup>	245	C/VV

 <sup>(1)</sup> Device mounted on FR4 material with 1-in² (6.45-cm²), 2-oz (0.071-mm) thick Cu.
 (2) Device mounted on FR4 material with minimum Cu mounting area.



# **5.3 Typical MOSFET Characteristics**

 $T_A = 25$ °C (unless otherwise stated)

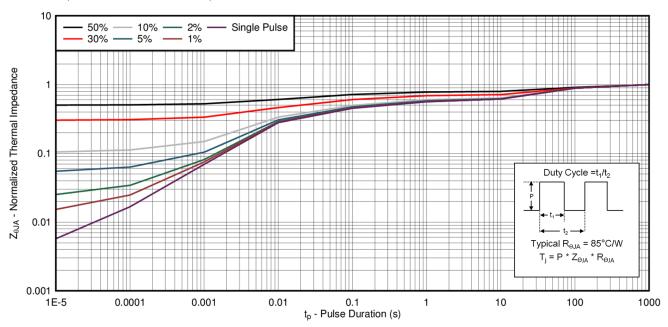
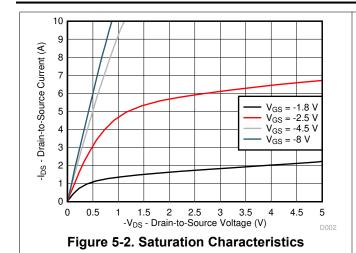
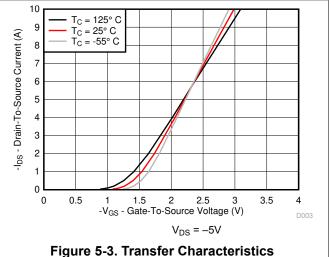
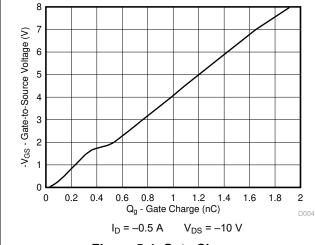


Figure 5-1. Transient Thermal Impedance







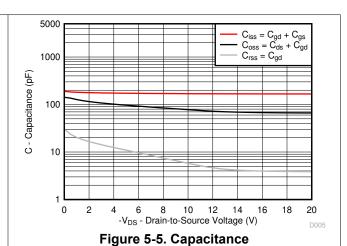


Figure 5-4. Gate Charge

250  $T_{C} = 25^{\circ} \text{ C}, \ I_{D} = -0.5 \text{ A}$   $T_{C} = 125^{\circ} \text{ C}, \ I_{D} = -0.5 \text{ A}$ 225 (mD) 200 On-State Resistance 175 150 125 100 75 50 25 0 0 8 -V<sub>GS</sub> - Gate-To-Source Voltage (V)

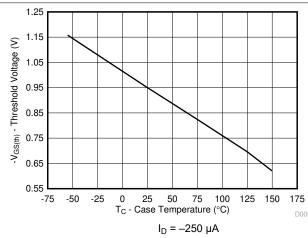


Figure 5-7. On-State Resistance vs Gate-to-Source Voltage

Figure 5-6. Threshold Voltage vs Temperature

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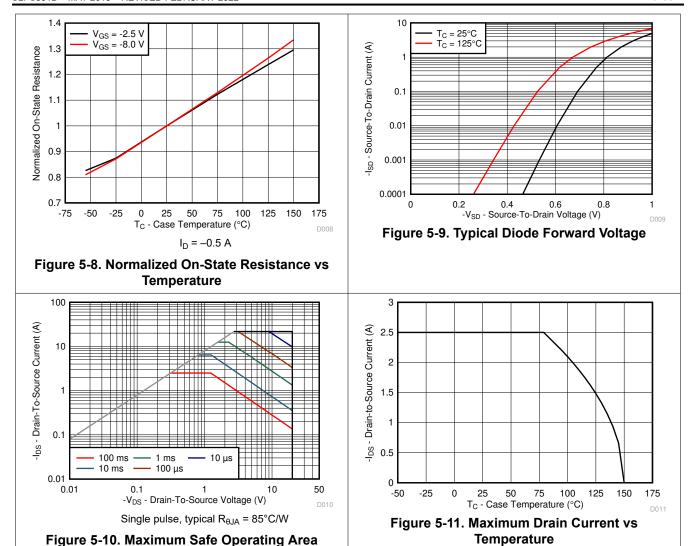


Figure 5-10. Maximum Safe Operating Area

## **6 Device and Documentation Support**

## 6.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### **6.2 Support Resources**

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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#### 6.3 Trademarks

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### 6.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 6.5 Glossary

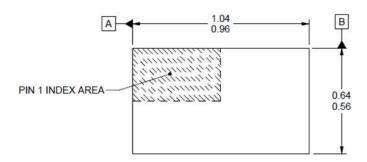
TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

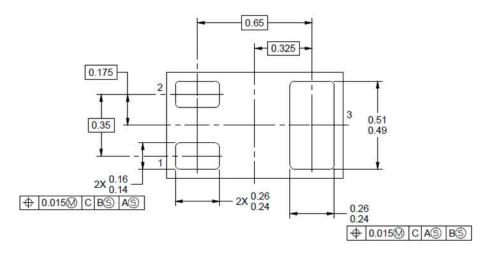
## 7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

#### 7.1 Mechanical Dimensions







- A. All linear dimensions are in millimeters (dimensions and tolerancing per AME T14.5M-1994).
- B. This drawing is subject to change without notice.
- C. This package is a PB-free solder land design.

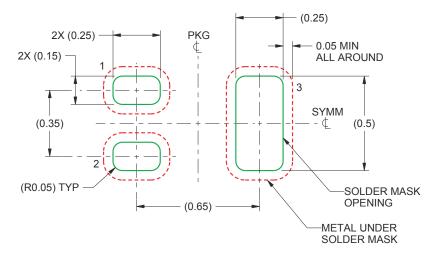
Table 7-1. Pin Configuration

Gonnigaration						
POSITION	DESIGNATION					
Pin 1	Gate					
Pin 2	Source					
Pin 3	Drain					

Submit Document Feedback

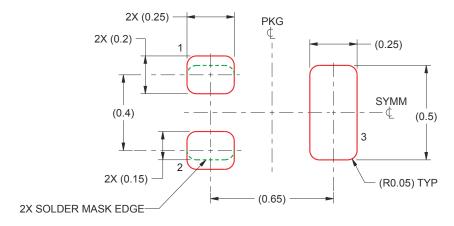


## 7.2 Recommended Minimum PCB Layout



- A. All dimensions are in millimeters.
- B. For more information, see FemtoFET Surface Mount Guide (SLRA003D).

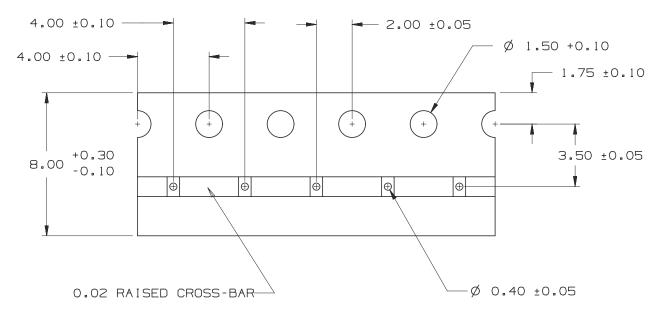
## 7.3 Recommended Stencil Pattern

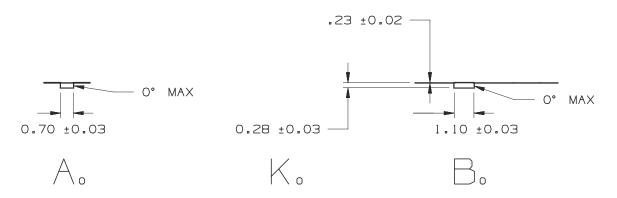


A. All dimensions are in millimeters.



## 7.4 CSD68830F4 Embossed Carrier Tape Dimensions





A. Pin 1 is oriented in the top-right quadrant of the tape enclosure (quadrant 2), closest to the carrier tape sprocket holes.

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#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
CSD25484F4	Active	Production	PICOSTAR (YJJ)   3	3000   LARGE T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	G3
CSD25484F4.B	Active	Production	PICOSTAR (YJJ)   3	3000   LARGE T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	G3
CSD25484F4T	Active	Production	PICOSTAR (YJJ)   3	250   SMALL T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	G3
CSD25484F4T.B	Active	Production	PICOSTAR (YJJ)   3	250   SMALL T&R	Yes	NIAU	Level-1-260C-UNLIM	-55 to 150	G3

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

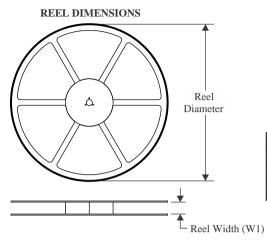
<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

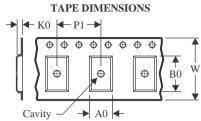
<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

## **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

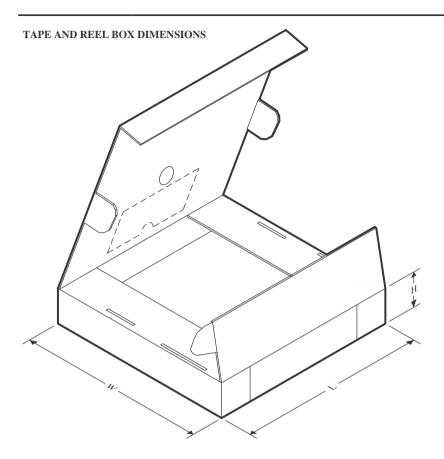


#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD25484F4	PICOSTAF	YJJ	3	3000	180.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2
CSD25484F4T	PICOSTAF	YJJ	3	250	180.0	8.4	0.7	1.1	0.46	4.0	8.0	Q2



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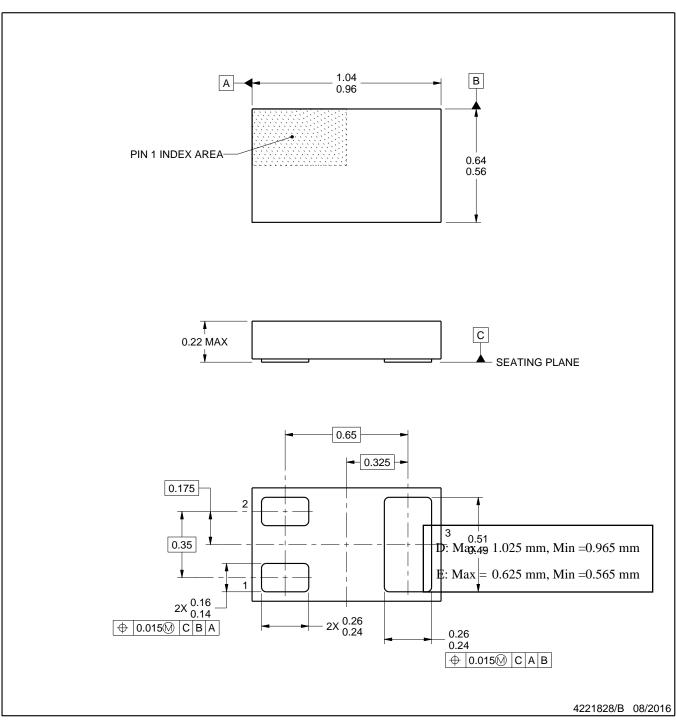


### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD25484F4	PICOSTAR	YJJ	3	3000	182.0	182.0	20.0
CSD25484F4T	PICOSTAR	YJJ	3	250	182.0	182.0	20.0



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#### NOTES:

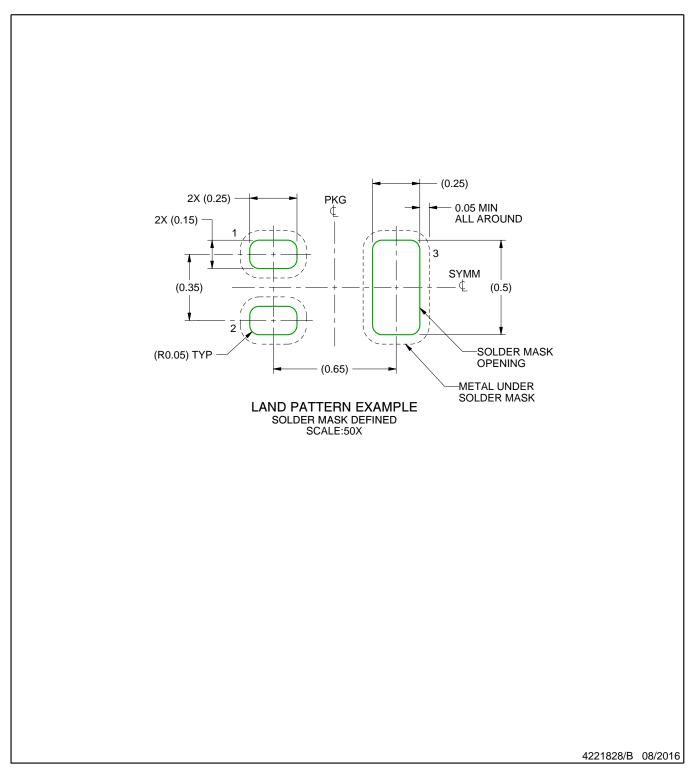
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- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M

  2. This drawing is subject to change without notice.
- 3. This package is a Pb-free bump design. Bump finish may vary. To determine the exact finish, refer to the device datasheet or contact a local TI representative.



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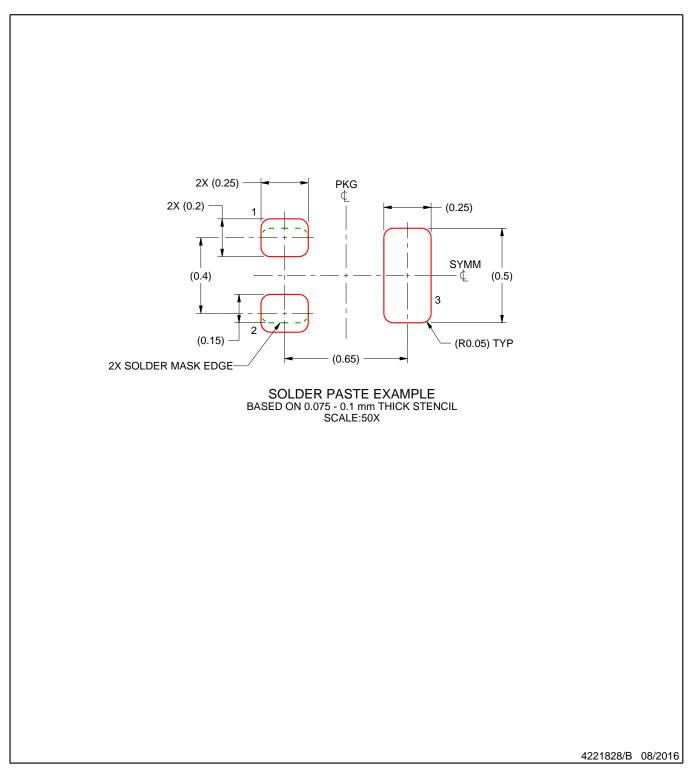


NOTES: (continued)

4. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).



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NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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